

Maximum Ratings

Tj=25°C, unless otherwise specified

Parameter	Symbol	Condition		Value	Unit		
Input Boost MOSFET							
Drain to source breakdown voltage	V_{DS}			650	V		
DC drain current	I _D	T _j =T _j max	T _h =25°C T _h =80°C	100 75	А		
Pulsed drain current	I _{Dpulse}	t _p limited by T _j max		400	А		
Power dissipation	P _{tot}	$T_j=T_j$ max	T _h =25°C T _h =80°C	329 184	w		
Gate-source peak voltage	V_{GS}			25	V		
Maximum Junction Temperature	T _j max			150	°C		
Input Boost Diode							
Peak Repetitive Reverse Voltage	V_{RRM}	T _j =25°C		600	V		
DC forward current	I _F	$T_j=T_j$ max	T _h =25°C T _h =80°C	115 77	А		
Repetitive peak forward current	I _{FRM}	t _p limited by T _j max		240	А		
Power dissipation	P _{tot}	$T_j=T_j$ max	T _h =25°C T _h =80°C	179 100	W		
Maximum Junction Temperature	T _j max			150	°C		

copyright by Vincotech 1 Revision: 3





target datasheet

Maximum Ratings

Tj=25°C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit			
Thermal Properties							
Storage temperature	T _{stg}		-40+125	°C			
Operation temperature under switching condition	T _{op}		-40+(Tjmax - 25)	°C			
Insulation Properties							
Insulation voltage	V _{is}	t=2s DC voltage	4000	V			
Creepage distance			min 12,7	mm			
Clearance			min 12,7	mm			



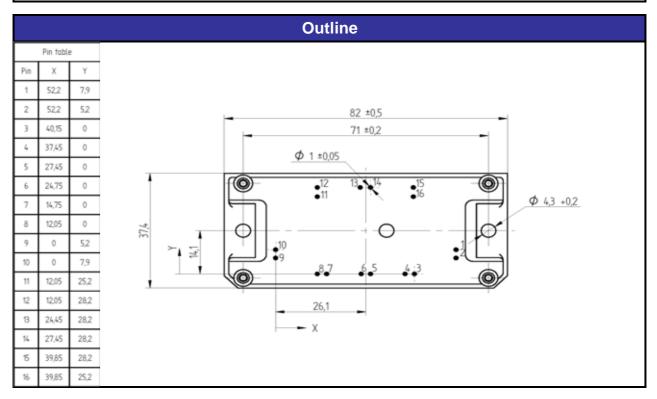
Characteristic Values

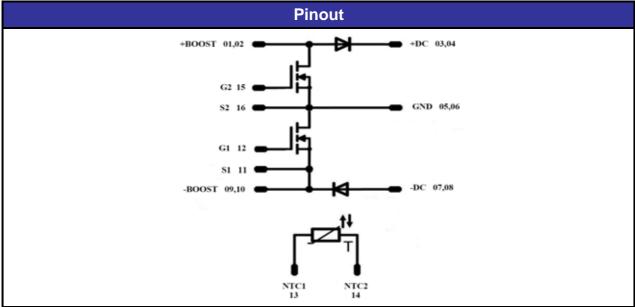
Parameter Sy			С	onditions				Value		Unit
			V _{GE} [V] or V _{GS} [V]	V _r [V] or V _{CE} [V] or V _{DS} [V]	I _C [A] or I _F [A] or I _D [A]	T _j	Min	Тур	Max	
Input Boost MOSFET										
Static drain to source ON resistance	R _{DS(on)}				69	Tj=25°C Tj=125°C		0,019 0,038		Ω
Gate threshold voltage	V _{(GS)th}	VGS=VDS			0,0005	Tj=25°C Tj=125°C	3	4	5	٧
Gate to Source Leakage Current	I _{gss}		20	0		Tj=25°C Tj=125°C			400	nA
Zero Gate Voltage Drain Current	I _{dss}		0	650		Tj=25°C Tj=125°C			2 200	μA
Turn On Delay Time	t _{d(ON)}					Tj=25°C Tj=125°C		36	200	
Rise Time	t _r	Rgoff=2,4 Ω Rgon=2,4 Ω				Tj=25°C Tj=125°C		90		1
Turn off delay time	t _{d(OFF)}					Tj=25°C Tj=125°C		130		ns
Fall time	t _f		10	400	80	Tj=25°C Tj=125°C		40		
Turn-on energy loss per pulse	Eon					Tj=25°C Tj=125°C		tbd		
Turn-off energy loss per pulse	E _{off}					Tj=125°C Tj=25°C Tj=125°C		tbd		mWs
Total gate charge	Qg					Tj=125 °C Tj=25 °C Tj=125 °C		360		
Gate to source charge	Q_{gs}		10	520	69	Tj=25°C		120		nC
Gate to drain charge	Q _{gd}					Tj=125°C Tj=25°C		140		
Input capacitance	C _{iss}					Tj=125°C		19600		
Output capacitance	C _{oss}	f=1MHz	0	100		Tj=25°C		400		pF
Reverse transfer capacitance	C _{rss}							12		1
Thermal resistance chip to heatsink per chip	R _{thJH}	Thermal grease thickness≤50um λ = 1 W/mK						0,38		K/W
Input Boost Diode										
Forward voltage	V _F				120	Tj=25°C		1,4		V
Reverse leakage current	I _{rm}			390	120	Tj=125°C Tj=25°C		1,3	200	μA
Peak recovery current					-	Tj=125°C				
						Tj=25°C		11	1000	
Reverse recovery time	I _{RRM}					Tj=125°C Tj=25°C		25 60	1000	A
Reverse recovery time Reverse recovery charge	t _{rr}	diF/dt = 200 A/us		390	120	Tj=125°C Tj=25°C Tj=125°C Tj=25°C		25	1000	A
Reverse recovery charge	t _{rr} Q _{rr}	diF/dt = 200 A/us		390	120	Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=25°C Tj=25°C Tj=25°C		25 60 138	1000	A ns μC
Reverse recovery charge Reverse recovered energy	t _{rr} Q _{rr} E _{rec} di(rec)max			390	120	Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=125°C Tj=125°C Tj=25°C		25 60 138 tbd	1000	A ns μC mWs
Reverse recovery charge	t _{rr} Q _{rr} E _{rec}			390	120	Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=25°C Tj=25°C		25 60 138 tbd	1000	A ns μC
Reverse recovery charge Reverse recovered energy Peak rate of fall of recovery current Thermal resistance chip to heatsink per chip	t _{rr} Q _{rr} E _{rec} di(rec)max /dt	Thermal grease thickness≤50um		390	120	Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=125°C Tj=125°C Tj=25°C		25 60 138 tbd tbd	1000	A ns μC mWs A/μs
Reverse recovery charge Reverse recovered energy Peak rate of fall of recovery current Thermal resistance chip to heatsink per chip Thermistor	t _{rr} Q _{rr} E _{rec} di(rec)max /dt R _{thJH}	Thermal grease thickness≤50um		390	120	Ti=125°C Ti=25°C		25 60 138 tbd tbd tbd	1000	A ns μC mWs A/μs
Reverse recovery charge Reverse recovered energy Peak rate of fall of recovery current Thermal resistance chip to heatsink per chip Thermistor Rated resistance	t _{rr} Q _{rr} E _{rec} di(rec)max /dt R _{thJH}	Thermal grease thickness≤50um λ = 1 W/mK		390	120	Ti=125°C Ti=25°C		25 60 138 tbd tbd		A ns μC mWs A/μs K/W
Reverse recovery charge Reverse recovered energy Peak rate of fall of recovery current Thermal resistance chip to heatsink per chip Thermistor Rated resistance Deviation of R100	$\begin{array}{c} t_{rr} \\ Q_{rr} \\ \\ E_{rec} \\ \hline di(rec)max \\ /dt \\ \\ R_{thJH} \\ \\ \\ R \\ \Delta R/R \\ \end{array}$	Thermal grease thickness≤50um		390	120	Ti=125°C Ti=25°C Ti=125°C Ti=125°C	-5	25 60 138 tbd tbd tbd 0,70	5	A ns μC mWs A/μs K/W
Reverse recovery charge Reverse recovered energy Peak rate of fall of recovery current Thermal resistance chip to heatsink per chip Thermistor Rated resistance Deviation of R100 Power dissipation	t _{rr} Q _{rr} E _{rec} di(rec)max /dt R _{thJH}	Thermal grease thickness≤50um λ = 1 W/mK		390	120	Ti=125°C Ti=25°C T=100°C T=25°C	-5	25 60 138 tbd tbd tbd 0,70		A ns μC mWs A/μs K/W
Reverse recovery charge Reverse recovered energy Peak rate of fall of recovery current Thermal resistance chip to heatsink per chip Thermistor Rated resistance Deviation of R100 Power dissipation Power dissipation constant	t _{rr} Q _{rr} E _{rec} di(rec)max /dt R _{thJH}	Thermal grease thickness≤50um λ = 1 W/mK		390	120	Ti=125°C Ti=25°C	-5	25 60 138 tbd tbd tbd 0,70		A ns μC mWs A/μs K/W Ω mW/K
Reverse recovery charge Reverse recovered energy Peak rate of fall of recovery current Thermal resistance chip to heatsink per chip Thermistor Rated resistance Deviation of R100 Power dissipation	t _{rr} Q _{rr} E _{rec} di(rec)max /dt R _{thJH}	Thermal grease thickness≤50um λ = 1 W/mK R100=1486 Ω Tol. ±3%		390	120	Ti=125°C Ti=25°C T=100°C T=25°C	-5	25 60 138 tbd tbd tbd 0,70		A ns μC mWs A/μs K/W



Ordering Code and Marking - Outline - Pinout

Ordering Code & Marking				
Version	Ordering Code	in DataMatrix as	in packaging barcode as	
without thermal paste 17mm housing	10-F106BIB020FK-M285L	M285L	M285L	







PRODUCT STATUS DEFINITIONS

Datasheet Status	Product Status	Definition
Target	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice. The data contained is exclusively intended for technically trained staff.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data may be published at a later date. Vincotech reserves the right to make changes at any time without notice in order to improve design. The data contained is exclusively intended for technically trained staff.
Final	Full Production	This datasheet contains final specifications. Vincotech reserves the right to make changes at any time without notice in order to improve design. The data contained is exclusively intended for technically trained staff.

DISCLAIMER

The information given in this datasheet describes the type of component and does not represent assured characteristics. For tested values please contact Vincotech. Vincotech reserves the right to make changes without further notice to any products herein to improve reliability, function or design. Vincotech does not assume any liability arising out of the application or use of any product or circuit described herein; neither does it convey any license under its patent rights, nor the rights of others.

LIFE SUPPORT POLICY

Vincotech products are not authorised for use as critical components in life support devices or systems without the express written approval of Vincotech.

As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in labelling can be reasonably expected to result in significant injury to the user.
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.